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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		Applicant: Ulrich Bonne	
		Filing Date: January 27, 2004	Group Art: unknown 3746

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Examiner Initial	Document No.	Date	Name	
PJB	906,468	12/1908	Steynis	
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	4,216,096	08/1980	Pare et al.	
	4,228,815	10/1980	Juffa et al.	
↓	4,234,800	11/1980	Kenly	
PJB	4,383,976	05/1983	Notaro	

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	4,735,082	04/1988	Kolloff	
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PJB	5,034,198	07/1991	Kaiga et al.	

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	6,308,553	10/2001	Bonne et al.	
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PJB	WO 92/06369	04/1992	PCT	
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EXAMINER: <i>[Signature]</i>	
DATE CONSIDERED: 12/11/06	

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